


<b>Search Notes</b> 	<b>Application/Control No.</b> 10771590	<b>Applicant(s)/Patent Under Reexamination</b> CHEN ET AL.
	<b>Examiner</b> DAVID Y ENG	<b>Art Unit</b> 2155

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES			
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INTERFERENCE SEARCH			
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